

Subject Description Form

Subject Code	EE2003 / EE2003A / EE2003B
Subject Title	Electronics
Credit Value	3
Level	2
Pre-requisite/ Co-requisite/ Exclusion	Pre-requisite for EE2003: EE2002 Pre-requisite for EE2003A: EE2002A Pre-requisite for EE2003B: EE2002B
Objectives	<ol style="list-style-type: none"> To introduce the principles and techniques used in the operations and analysis of fundamental classes of semiconductor-based electronic devices and circuits, including diodes and diode circuits, bipolar junction transistors (BJTs) and BJT amplifiers, metal-oxide-semiconductor field-effect transistors (MOSFETs) and MOSFET amplifiers as well as operational amplifiers (op-amps) and op-amp circuits. To introduce the principles and techniques used in the implementation of frequency domain analysis on first-order ac circuits with sinusoidal driving sources.
Intended Learning Outcomes	<p>Upon completion of the subject, students will be able to:</p> <ol style="list-style-type: none"> Describe the operating principles of the fundamental classes of semiconductor-based electronic devices and circuits. Apply the appropriate techniques to analyze the fundamental classes of semiconductor-based electronic devices and circuits. Implement the frequency domain analysis on first-order ac circuits with sinusoidal driving sources. Conduct relevant laboratory experiments and report the findings with appropriate techniques and tools.
Subject Synopsis/ Indicative Syllabus	<p>Syllabus:</p> <ol style="list-style-type: none"> <u>Diodes and Diode Circuits</u> Semiconductor materials and properties. Properties of p-n junctions. Structure, operation and characteristics of p-n junction diodes. Ideal and practical p-n junction diodes. Analysis of basic diode circuits. Analysis of specific diode circuits: rectifiers, peak detectors, clippers, clampers, etc. Load line concept and analysis. <u>BJTs and BJT Amplifiers</u> Structures, operations and characteristics of n-p-n and p-n-p BJTs. DC analysis, load line and design techniques of BJT circuits. DC biasing schemes. Basic configurations, operations and characteristics of BJT amplifiers. AC analysis, load line and design techniques. Small-signal equivalent circuits and parameters. Small-signal voltage gain, current gain, input resistance and output resistance. Loading effect. <u>MOSFETs and MOSFET Amplifiers</u> Structures, operations and characteristics of n-channel and p-channel MOSFETs. DC analysis, load line and design techniques of MOSFET circuits. DC biasing schemes. Basic configurations, operations and characteristics of MOSFET amplifiers. AC analysis, load line and design techniques. Small-signal equivalent circuits and parameters. Small-signal voltage gain, current gain, input resistance and output resistance. Loading effect.

	<p>4. <u>Op-Amps and Op-Amp Circuits</u></p> <p>Transistor-level diagram and basic operation of op-amps. Ideal and practical op-amp equivalent circuits and characteristics. Golden rules. Basic op-amp circuits: inverting, non-inverting, summing, difference, integrating and differentiating amplifiers. Specific op-amp circuits: voltage follower, current-to-voltage converter, voltage-to-current converter, instrumentation amplifier etc. Design applications.</p> <p>5. <u>Frequency Domain Analysis</u></p> <p>Power, voltage and current gains on linear and logarithmic scales. Concepts of “bel” and “decibel”. Concepts of time t, angular frequency $j\omega$ and complex angular frequency s domains. Transfer functions in $j\omega$ and s domains. Introduction to Bode plot. Derivation of transfer functions of first-order ac circuits with sinusoidal driving sources. Implementation of Bode magnitude and phase plots. Concepts of pole and zero, corner/cutoff frequency as well as bandwidth.</p> <p>Laboratory Experiments:</p> <ol style="list-style-type: none"> EE2003-E01: Basic Diode Circuits. EE2003-E02: BJT Circuits EE2003-E03: Op-Amp Circuits. 																																												
<p>Teaching/ Learning Methodology</p>	<p>Assignments</p>	<p>a, b, c</p>	<p>Through assignments, students learn to <i>apply</i> the appropriate techniques to solve problems and <i>get familiarized</i> with the concepts they have learnt.</p>																																										
	<p>Lectures, supplemented with interactive questions and answers</p>	<p>a, b, c</p>	<p>In lectures, students are introduced to the <i>knowledge</i> of the subject, and <i>comprehension</i> is strengthened with interactive Q&A.</p>																																										
	<p>Tutorials, where problems are discussed and are given to students for them to solve</p>	<p>a, b, c</p>	<p>In tutorials, students <i>apply</i> what they have learnt in solving the problems given by the tutor.</p>																																										
	<p>Laboratory sessions, where students will perform experimental verifications. They will have to record results and write a report on one of the experiments.</p>	<p>a, b, d</p>	<p>Students <i>acquire</i> hands-on experience in using electronic equipment and <i>apply</i> what they have learnt in lectures/tutorials to experimentally validate the theoretical investigations.</p>																																										
<p>Assessment Methods in Alignment with Intended Learning Outcomes</p>	<table border="1"> <thead> <tr> <th data-bbox="424 1603 868 1738" rowspan="2">Specific assessment methods/tasks</th> <th data-bbox="868 1603 1038 1738" rowspan="2">% Weighting</th> <th colspan="4" data-bbox="1038 1603 1471 1686">Intended Subject Learning Outcomes to be Assessed</th> </tr> <tr> <th data-bbox="1038 1686 1158 1738">a</th> <th data-bbox="1158 1686 1262 1738">b</th> <th data-bbox="1262 1686 1366 1738">c</th> <th data-bbox="1366 1686 1471 1738">d</th> </tr> </thead> <tbody> <tr> <td data-bbox="424 1738 868 1794">1. Assignments</td> <td data-bbox="868 1738 1038 1794">16%</td> <td data-bbox="1038 1738 1158 1794">✓</td> <td data-bbox="1158 1738 1262 1794">✓</td> <td data-bbox="1262 1738 1366 1794">✓</td> <td data-bbox="1366 1738 1471 1794"></td> </tr> <tr> <td data-bbox="424 1794 868 1850">2. Mid-semester test/ Quizzes</td> <td data-bbox="868 1794 1038 1850">16%</td> <td data-bbox="1038 1794 1158 1850">✓</td> <td data-bbox="1158 1794 1262 1850">✓</td> <td data-bbox="1262 1794 1366 1850">✓</td> <td data-bbox="1366 1794 1471 1850"></td> </tr> <tr> <td data-bbox="424 1850 868 1906">3. Laboratory works and reports</td> <td data-bbox="868 1850 1038 1906">18%</td> <td data-bbox="1038 1850 1158 1906">✓</td> <td data-bbox="1158 1850 1262 1906">✓</td> <td data-bbox="1262 1850 1366 1906">✓</td> <td data-bbox="1366 1850 1471 1906">✓</td> </tr> <tr> <td data-bbox="424 1906 868 1962">4. Examination</td> <td data-bbox="868 1906 1038 1962">50%</td> <td data-bbox="1038 1906 1158 1962">✓</td> <td data-bbox="1158 1906 1262 1962">✓</td> <td data-bbox="1262 1906 1366 1962">✓</td> <td data-bbox="1366 1906 1471 1962"></td> </tr> <tr> <td data-bbox="424 1962 868 1995">Total</td> <td data-bbox="868 1962 1038 1995">100%</td> <td colspan="4" data-bbox="1038 1962 1471 1995"></td> </tr> </tbody> </table>					Specific assessment methods/tasks	% Weighting	Intended Subject Learning Outcomes to be Assessed				a	b	c	d	1. Assignments	16%	✓	✓	✓		2. Mid-semester test/ Quizzes	16%	✓	✓	✓		3. Laboratory works and reports	18%	✓	✓	✓	✓	4. Examination	50%	✓	✓	✓		Total	100%				
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	Explanation of the appropriateness of the assessment methods in assessing the intended learning outcomes:	
	Specific assessment methods/tasks	Remark
	Assignments	Students will be given multiple assignments to evaluate their ability to apply the appropriate techniques for analysis of semiconductor-based electronic devices and circuits.
	Laboratory works and reports	Students will be required to perform three experiments and submit a report on the experiments. Assessment will be based on their ability to apply what they have learnt, report organization skills, and problem-solving techniques.
	Mid-semester test/ Quizzes	There will be test(s) to evaluate students' achievement of all the learning outcomes and give feedback to them for prompt improvement.
	End-of-semester Examination	There will be an end-of-semester examination to assess students' achievement of all the learning outcomes. These are mainly summative in nature.
Student Study Effort Expected	Class contact:	
	▪ Lecture/Tutorial	30 Hrs.
	▪ Laboratory	9 Hrs.
	Other student study effort:	
	▪ Self-study and assignments	52 Hrs.
	▪ Laboratory logbook & report writings	14 Hrs.
	Total student study effort	105 Hrs.
Reading List and References	<p>Textbook:</p> <ol style="list-style-type: none"> 1. Donald A. Neamen, <i>Microelectronics: Circuit Analysis and Design</i>, 4th ed., Boston: McGraw-Hill, 2010. <p>References:</p> <ol style="list-style-type: none"> 1. Adel S. Sedra, Kenneth C. Smith, Tony C. Carusone, and Vincent Gaudet, <i>Microelectronic Circuits</i>, 8th international edition, NY: Oxford University Press, 2021 2. G. Rizzoni and James Kearns, <i>Principles and Applications of Electrical Engineering</i>, 6th ed., New York: McGraw-Hill, 2016. 3. W.H. Hayt, J.E. Kemmerly and S.M. Durbin, <i>Engineering Circuit Analysis</i>, 9th ed., New York: McGraw-Hill, 2018. 4. A.H. Robbins and W.C. Miller, <i>Circuit Analysis: Theory and Practice</i>, Thomson Learning, 5th ed., 2013. 	